


<b>Search Notes</b> 	<b>Application/Control No.</b> 10539194	<b>Applicant(s)/Patent Under Reexamination</b> KERR ET AL.
	<b>Examiner</b> Ho, Huy C	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
455	418	3/16/07	HH
	433	3/16/07	HH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST image and keyword search in USPATConclusion, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB (See attached search strat	10/13/06	HH
Update search	3/16/07	HH

INTERFERENCE SEARCH			
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